

## Ultrafast recovery diode

### Main product characteristics

$I_{F(AV)}$	2 x 50 A
$V_{RRM}$	200 V
$T_j$ (max)	150° C
$V_F$ (typ)	0.72 V
$t_{rr}$ (typ)	30 ns

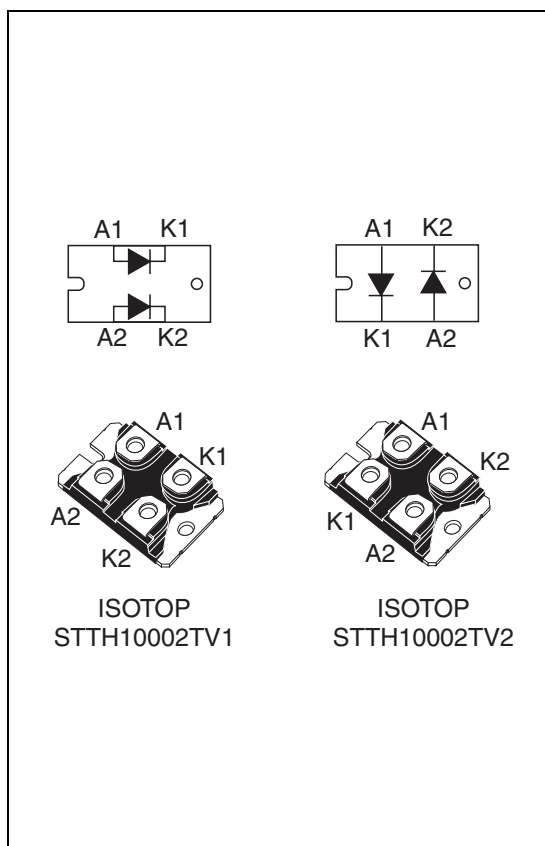
### Features and benefits

- Very low forward losses
- Low recovery time
- High surge current capability
- Insulated
  - Insulating voltage = 2500 V<sub>rms</sub>
  - Capacitance = 45 pF

### Description

The STTH10002 is a dual rectifier suited for welding equipment, and high power industrial applications.

Packaged in ISOTOP, this device is intended for use in the secondary rectification of power converters.



### Order codes

Part Number	Marking
STTH10002TV1	STTH10002TV1
STTH10002TV2	STTH10002TV2

# 1 Characteristics

**Table 1. Absolute ratings (limiting values at  $T_j = 25^\circ\text{C}$ , unless otherwise specified)**

Symbol	Parameter		Value	Unit
$V_{RRM}$	Repetitive peak reverse voltage		200	V
$I_{F(RMS)}$	RMS forward current	Per diode	150	A
$I_{F(AV)}$	Average forward current, $\delta = 0.5$	Per diode $T_c = 100^\circ\text{C}$	50	A
		Per device $T_c = 95^\circ\text{C}$		
$I_{FSM}$	Surge non repetitive forward current	$t_p = 10\text{ ms}$ Sinusoidal	750	A
$T_{stg}$	Storage temperature range		-55 to + 175	$^\circ\text{C}$
$T_j$	Maximum operating junction temperature		150	$^\circ\text{C}$

**Table 2. Thermal parameters**

Symbol	Parameter		Value	Unit
$R_{th(j-c)}$	Junction to case	Per diode	1	$^\circ\text{C/W}$
		Total	0.55	
$R_{th(c)}$	Coupling		0.1	

When the two diodes 1 and 2 are used simultaneously:

$$\Delta T_j(\text{diode } 1) = P(\text{diode } 1) \times R_{th(j-c)} (\text{Per diode}) + P(\text{diode } 2) \times R_{th(c)}$$

**Table 3. Static electrical characteristics**

Symbol	Parameter	Test conditions		Min.	Typ	Max.	Unit
$I_R^{(1)}$	Reverse leakage current	$T_j = 25^\circ\text{C}$	$V_R = V_{RRM}$			50	$\mu\text{A}$
		$T_j = 125^\circ\text{C}$			50	500	
$V_F^{(2)}$	Forward voltage drop	$T_j = 25^\circ\text{C}$	$I_F = 50\text{ A}$			1	V
			$I_F = 100\text{ A}$			1.15	
		$T_j = 125^\circ\text{C}$	$I_F = 100\text{ A}$		0.90	1.0	
			$I_F = 50\text{ A}$		0.72	0.80	
$T_j = 150^\circ\text{C}$	$I_F = 50\text{ A}$		0.86	0.97			
	$I_F = 100\text{ A}$						

1. Pulse test:  $t_p = 5\text{ ms}$ ,  $\delta < 2\%$

2. Pulse test:  $t_p = 380\text{ }\mu\text{s}$ ,  $\delta < 2\%$

To evaluate the conduction losses use the following equation:

$$P = 0.63 \times I_{F(AV)} + 0.0034 I_{F(RMS)}^2$$

Table 4. Dynamic characteristics

Symbol	Parameter	Test conditions	Min.	Typ	Max.	Unit
$t_{rr}$	Reverse recovery time	$I_F = 1 \text{ A}$ , $dI_F/dt = -50 \text{ A}/\mu\text{s}$ , $V_R = 30 \text{ V}$ , $T_j = 25 \text{ }^\circ\text{C}$		53	65	ns
		$I_F = 1 \text{ A}$ , $dI_F/dt = -200 \text{ A}/\mu\text{s}$ , $V_R = 30 \text{ V}$ , $T_j = 25 \text{ }^\circ\text{C}$		30	37	
$I_{RM}$	Reverse recovery current	$I_F = 50 \text{ A}$ , $dI_F/dt = 200 \text{ A}/\mu\text{s}$ , $V_R = 160 \text{ V}$ , $T_j = 125 \text{ }^\circ\text{C}$		10	13	A
$t_{fr}$	Forward recovery time	$I_F = 50 \text{ A}$ , $dI_F/dt = 200 \text{ A}/\mu\text{s}$ $V_{FR} = 1.1 \times V_{Fmax}$ , $T_j = 25 \text{ }^\circ\text{C}$		180		ns
$V_{FP}$	Forward recovery voltage	$I_F = 50 \text{ A}$ , $dI_F/dt = 200 \text{ A}/\mu\text{s}$ , $T_j = 25 \text{ }^\circ\text{C}$		1.6		V

Figure 1. Peak current versus duty cycle

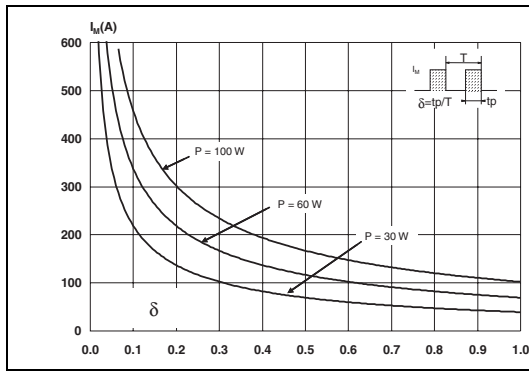


Figure 2. Forward voltage drop versus forward current (typical values, per diode)

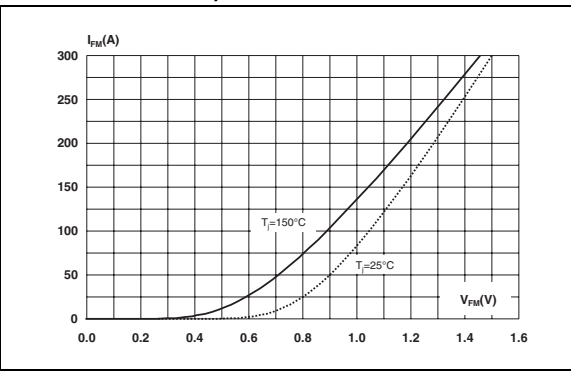


Figure 3. Forward voltage drop versus forward current (maximum values, per diode)

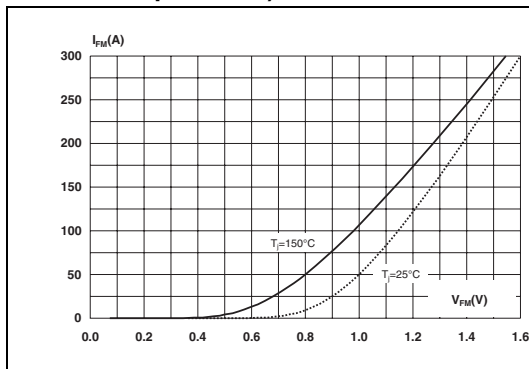
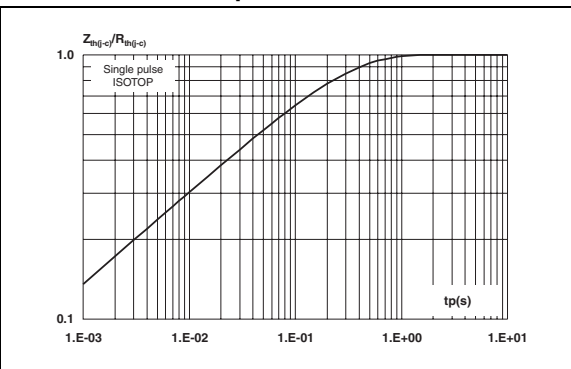
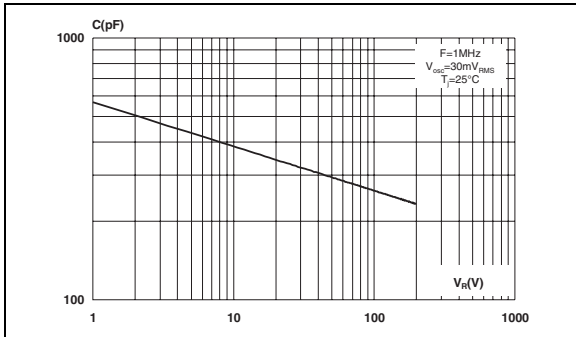


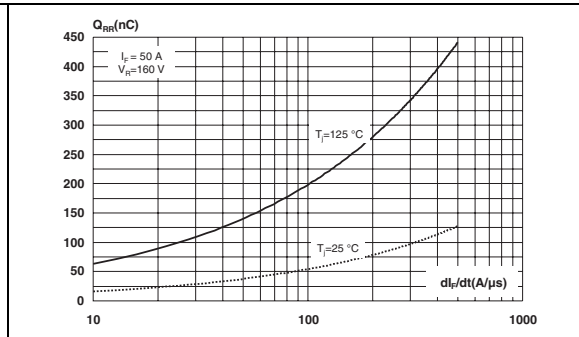
Figure 4. Relative variation of thermal impedance, junction to case, versus pulse duration



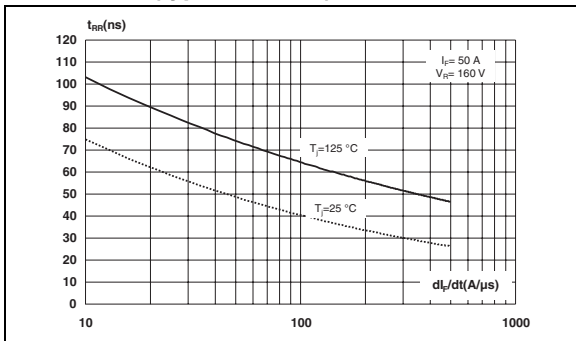
**Figure 5. Junction capacitance versus reverse applied voltage (typical values)**



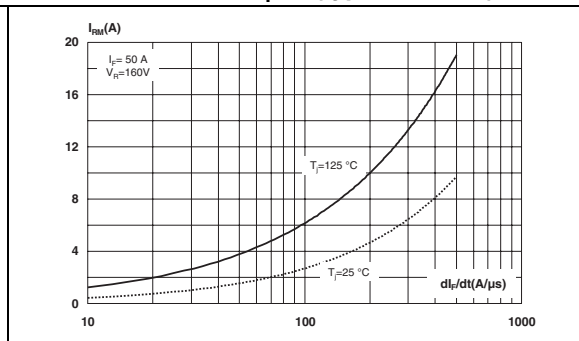
**Figure 6. Reverse recovery charges versus  $di_F/dt$  (typical values)**



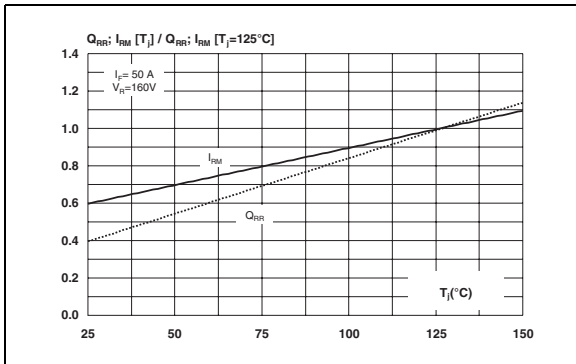
**Figure 7. Reverse recovery time versus  $di_F/dt$  (typical values)**



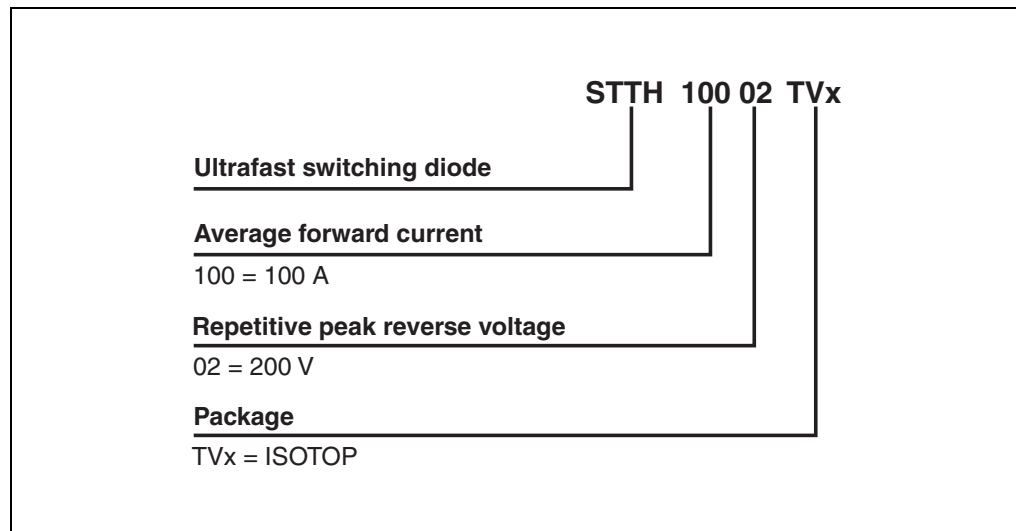
**Figure 8. Peak reverse recovery current versus  $di_F/dt$  (typical values)**



**Figure 9. Dynamic parameters versus junction temperature**



## 2 Ordering information scheme



### 3 Package information

Table 5. ISOTOP dimensions

REF.	DIMENSIONS			
	Millimeters		Inches	
	Min.	Max.	Min.	Max.
A	11.80	12.20	0.465	0.480
A1	8.90	9.10	0.350	0.358
B	7.8	8.20	0.307	0.323
C	0.75	0.85	0.030	0.033
C2	1.95	2.05	0.077	0.081
D	37.80	38.20	1.488	1.504
D1	31.50	31.70	1.240	1.248
E	25.15	25.50	0.990	1.004
E1	23.85	24.15	0.939	0.951
E2	24.80 typ.		0.976 typ.	
G	14.90	15.10	0.587	0.594
G1	12.60	12.80	0.496	0.504
G2	3.50	4.30	0.138	0.169
F	4.10	4.30	0.161	0.169
F1	4.60	5.00	0.181	0.197
P	4.00	4.30	0.157	0.69
P1	4.00	4.40	0.157	0.173
S	30.10	30.30	1.185	1.193

In order to meet environmental requirements, ST offers these devices in ECOPACK® packages. These packages have a lead-free second level interconnect. The category of second level interconnect is marked on the package and on the inner box label, in compliance with JEDEC Standard JESD97. The maximum ratings related to soldering conditions are also marked on the inner box label. ECOPACK is an ST trademark. ECOPACK specifications are available at: [www.st.com](http://www.st.com).

## 4 Ordering information

Part Number	Marking	Package	Weight	Base qty	Delivery mode
STTH10002TV1	STTH10002TV1	ISOTOP	27 g	10	Tube
STTH10002TV2	STTH10002TV2	ISOTOP	27 g	10	Tube

## 5 Revision history

Date	Revision	Description of Changes
05-Apr-2006	1	First issue

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